

Notice of References Cited	Application/Control No. 10/747,924	Applicant(s)/Patent Under Reexamination LAFORTUNE, JEFFREY MARK	
	Examiner Matthew D. Matzek	Art Unit 1771	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0008592	01-2006	Badyal et al.	427/569
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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